

Product Datasheet - Technical Specifications



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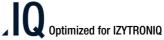


Test Instruments for Measuring the Electrical Safety of Devices

3-447-080-03 3/5.22

- Integrated test sequences for quickly testing operating equipment (preconfigured standards-compliant series of individual tests with subsequent documentation)
- Suitable for use by trained persons
- Quick access to measuring and test functions via the double rotary switch, direct selection keys and softkeys
- Automatic detection of DUT connection and protection category
- Unique multiple measurement permits convenient recording of several measuring points.
- Testing of various types of PRCDs such as PRCD-S and PRCD-K via integrated test sequences (including protective conductor resistance measurement for variants with switched PE as well)
- Comprehensive, legally secure preparation of test reports
- Extensive data management and storage concept for test results and single measurements (up to 50,000 data records*)
 – allocation of measurements/tests to devices and customers USB interfaces for data entry and transmission
- High-resolution, brilliant 4.3" TFT color display
- Compact, impact resistant housing with integrated rubber protector
- Extensive setting options for international use (language, keyboard, character set, date, time)

















SECUTEST DB+ database expansion (Z853R or feature KB01)

- Remote control via PC (IZYTRONIQ) is possible.
- Up to 24 user-defined test sequences (up to a total of 1200 test steps) can be created in IZYTRONIQ and uploaded to the test instrument.
- Additional database elements:
 - Property, building, floor and room for better structuring of large data sets
 - Department and cost center
 - Individual test interval for each test object
- Multi-print print out several/all test reports (to a connected Z721S thermal printer) which are available for a device under test by pressing just one key
- Create user-defined report templates and manage them in the test instrument, including company logo
- Export all data (master data and measured value) as a file to a USB flash drive
- Import all test object master data (no measured values) to the test instrument from IZYTRONIQ, or from a USB flash drive

SECUTEST DB COMFORT database expansion (Z853S or feature KD01)

- Additional database elements:
 - Medical test object for medical DUTs, with extended entry options
 - Individual test interval for each test object
- **Touch-Edit** editing can be started by pressing and holding the detail view of a test object in the main screen.
- Searches started with the "Search All" softkey scan the new "UDI" field (unique device identification) for medical devices as well.
- Move test objects "moving" (medical) devices within the tree can be initiated by pressing and holding the respective element in the tree display.
- QuickEdit when setting up a new DUT, not only can the ID be entered – all other fields can also be filled in at the same time as well.
- Auto-Store results of automatic test sequences are saved immediately under the selected test object.
- **Push-Print** send data directly to the PC (IZYTRONIQ) (data are not stored at the instrument).

^{* 1} data record = 1 DUT or location node or customer or individual measurement

Test Instruments for Measuring the Electrical Safety of Devices

Included Features

		Functions uring Function	Meas. Type,
Switch Position		urrent/Voltage	Connection Type
Single	measur	rements, rotary switch level: green	
RPE	R _{PE}	Protective conductor resistance Test current (200 mA) SECUTEST ST BASE10/PRO & SECULIFE ST BASE: 10 A ¹ (feature G01) & SECULIFE ST BASE25: 25 A ¹ (feature G02)	PE(TS) - P1 passive PE(TS) - P1 active PE(mains) - P1 PE(mains) - P1 clamp P1 - P2 ³
RINS	R _{INS}	Insulation resistance (PC I/PC II)	LN(TS) - PE(TS)
nins	U _{INS}	Test voltage	LN(TS) - P1 P1 - P2 ³ PE(mains) - P1 PE(TS) - P1 LN(TS) - P1//PE(TS)
İ PE	I _{PE} ~	Protective conductor current, RMS	Direct
	I _{PE} ~	AC component DC component Test voltage	Differential Alternative AT3-Adapter ² Clamp ²
İT	$I_{T\simeq}$	Touch current, RMS	Direct
	I _{T~} I _{T=} U _{LN}	AC component DC component Test voltage	Differential Alternative (P1) Permanent conn. Alternative (P1–P2)
ĪE	I _E ~	Device leakage current, RMS	Direct
-	I _{G~}	AC component	Differential
	I _{F=}	DC component	Alternative
	U _{LN}	Test voltage	AT3-Adapter ² Clamp ²
ΙA	I _A ~	Leakage current from the applied part, RMS	Direct (P1)
IA.	U _A	Test voltage	Alternative (P1) Perm. conn. (P1)
lР	I _P ∼	Patient leakage current, RMS	
	I _{P~}	AC component	Direct (P1)
	I _{P=}	DC component	Perm. conn. (P1)
	U _{LN}	Test voltage	
U	U <u>~</u>	Probe voltage, TRMS	PE - P1
	U _~	Alternating voltage component	PE - P1 (with mains*) * Polarity setting
	U ₌	Direct voltage component	Foldrity Setting
	U <u>~</u> U _~	Measuring voltage, TRMS ² Alternating voltage component ²	V – COM
	U ₌	Direct voltage component ²	V – COM (with mains
tprcd 4		PRCD time to trip for 30 mA PRCDs	
LI HOD	U _{LN}	Line voltage at the test socket	
P		ion test at the test socket	
	1	Current between L and N	-
	U	Voltage between L and N	-
	f	Frequency	Polarity setting
	Р	Active power	
	S	Apparent power	
	PF	Power factor	
Specia		ıring functions	
EL1	continu	on cord with adapter: ity, short-circuit, polarity (reversed wires ⁵)	EL1 adapter EL1 adapter (continui only) AT3-IIIE adapter VL2E adapter
EXTRA		ed for extensions within the framework of soft	
		nperature measurement ² with Pt100/Pt1000	
	IZ Cur sen	rent clamp measurement with current clamp	V – COM

^{10/25} A $R_{\mbox{\footnotesize{PF}}}$ measurements are only possible with line voltages of 115/230 V and line frequencies of 50/60 Hz.

Voltage measuring inputs only with test instruments including feature IO1

(e.g. SECUTEST ST PRO and SECULIFE ST BASE(25))

Connection for 2nd test probe for two-pole measurement with test instrument including feature H01 (e.g. SECUTEST ST PRO or SECULIFE ST BASE(25))

Measurement of time to trip isn't possible in IT systems

No checking for reversed wires takes place when the EL1 adapter is used.

Alternative = alternative measurement (equivalent leakage

current measurement)

Differential = differential current measurement

Direct = direct measurement

LN(TS) = short-circuited L and N conductors at test socket

P1 = measurement with test probe P1

P1-P2 = 2-pole measurement with test probes P1 and P2 PE-P1 = measurement between PE and test probe P1 PE(TS) = protective conductor at the test socket PE(mains) = protective conductor at the mains connection

Integrated Test Sequences

The test instrument includes preconfigured, integrated test sequences. The integrated test sequences can be used to comply with the following standards:

- VDE 0701-0702 / ÖVE E 8701 / SNR 462638 Ilnspection after repair, modification of electrical appliances -Periodic inspection on electrical appliances
- IEC 62353 / EN 62353 / VDE 0751-1 Medical electrical equipment -Recurrent test and test after repair of medical electrical equip-
- IEC 60974-4 / EN 60974-4 / VDE 0544-4 Arc welding equipment Part 4: Periodic inspection and testing
- NEN 3140

Bedrijfsvoering van elektrische installaties - Laagspanning

EN 50678 / VDE 0701

General procedure for verifying the effectiveness of the protective measures of electrical equipment after repair

EN 50699 / VDE 0702

Recurrent Test of Electrical Equipment

- IEC 62368 / EN 62368 / VDE 0868-1 Audio/video, information and communication technology equipment
- IEC 62911 / EN 62911 / VDE 0868-911 Audio, video and information technology equipment - Routine electrical safety testing in production

Availability of the individual integrated test sequences depends on the test instrument type (SECUTEST ST... or SECULIFE ST...), the selected features (order features) and the enabled extensions (activations).

The integrated test sequences are run in the orange rotary switch position. They're freely assignable, i.e. they can be individually assigned to the rotary switch positions (because there are more integrated test sequences than rotary switch positions).

The test instrument is preconfigured upon delivery and its configuration depends on numerous factors. Due to the great variety of possible combinations, listing them would go beyond the scope of this data sheet and has therefore been omitted.

Mains Connection Analysis

Line voltage and frequency are measured and compared with the data specified in the setup menu. Momentary voltage or nominal voltage in accordance with the standard is required, for instance in order to calculate measured values for the leakage current measurement.

Automatic Detection of Mains Connection Errors

The device automatically recognizes mains connection errors if the conditions in the following table have been fulfilled. The user is informed of the type of error, and all measuring functions are disabled in the event of danger.

Type of Mains Connection Error	Message	Condition	Measurements
Voltage at protective conductor PE to finger contact (START/STOP key)	Display	Press START / STOP key U > 25 V $key \rightarrow PE$: $< 1 M\Omega^{\frac{1}{2}}$	All measurements disabled
Protective conductor PE and phase conductor L reversed and/or neutral conductor N interrupted		Voltage at PE > 100 V	Not possible (no supply power)
Line voltage < 180 V / < 90 V (depending on mains)		$\begin{array}{c} U_{L\text{-N}} < 180 \text{ V} \\ U_{L\text{-N}} < 90 \text{ V} \end{array}$	Possible under certain circum- stances ¹
Test for IT/TN system	Display	Connection $N \rightarrow PE > 20 \text{ k}\Omega$	Possible under certain circumstances

^{1 10/25} A R_{PE} measurements are only possible with line voltages of 115/230 V and line frequencies of 50/60 Hz.

Analysis of DUT Connection and Condition

Depending on the measurement or how the DUT is connected, the following states are checked and displayed before measurement is begun:

Test Function			Condition
Short-circuit testL-N	Short-circuit	/ DUT starting current	$R \le 2.5 \Omega$
	No	short-circuit (AC test)	$R > 2.5 \Omega$
Open-circuit voltage U ₀ 4.	.3 V, short-circuit cı	ırrent I _K < 250 mA	
Short-circuit testLN-PE		Short-circuit	$R \le 2 k\Omega$
	No	short-circuit (AC test)	$R > 2 k\Omega$
Open-circuit voltage U ₀ 23	30 V AC, short-circ	uit current I _K < 1.5 mA	
On test		On (DUT passive)	$R < 250 \text{ k}\Omega$
		Off (DUT active)	$R > 300 \text{ k}\Omega$
Open-circuit voltage U ₀ 23	30 V AC, short-circ	uit current I _K < 1.5 mA	
Switchable control	ched on automatically	$R > 500 \Omega$	
	Рориг	(switch off DUT first)	$R < 500 \Omega$
Probe test		No probe	$R > 2 M\Omega$
		Probe detected	$R < 500 \text{ k}\Omega$
Protection class detectio	n (only with country	specific variant 1)	
	Protective	conductor found: PC I	R < 1 Ω
	ective conductor: PC II	R > 10 Ω	
Safety shutdown			
Triggered at following resi	> 10 mA / > 30 mA		
Triggered at following pro	be current values	For leakage current measurement	$>$ 30 mA 2
During pro	> 250 mA		

Test Function		Condition
Connection test (on	ly with country specific variant ¹)	
Checks whether the	DUT is connected to the test socket.	
	DUT power cable found	R < 1 Ω
	No DUT power cable	$R > 10 \Omega$
Insulation test	DUT set up in a well-insulated fashion	$R \ge 500 \text{ k}\Omega$
	DUT set up in a poorly insulated fashion	$R < 500 \text{ k}\Omega$
PE mains - PE socke	et: Open-circuit voltage U_0 50 V DC, I_K < 2 mA	
Overcurrent protecti		
at:Our SECUTEST ST But ments permit active tes up to 16 A. The test so with 16 A fuses to this dis also 16 A. Starting cu objects for which a star	of a continuous flow of current via the test socket ASE10/PRO and SECULIFE ST BASE(25) test instructing of devices with nominal current (load current) of cket on the respective test instrument is equipped end, and the switching capacity of the internal relays urrent of up to 30 A is permissible. In the case of test ting current of greater than 30 A can be expected, d the use of a test adapter for larger starting currer from the AT3 series	I > 16.5 A

¹ Applies to M7050 with feature B00, B09

Features

The test instruments are available with various features. These can be selected when placing an order. The basic instruments include the following features:

	Features	SECUTEST ST BASE	SECUTEST ST BASE10	SECUTEST ST PRO	SECULIFE ST BASE	SECULIFE ST BASE25
Touchscreen / keyboard	E01			•	•	•
10 A RPE test current	G01		•	•	•	
25 A RPE test current	G02					•
2 nd test probe	H01			•	•	•
Voltage measuring input *	101			•	•	•
Integrated test sequences for EN 50678 / VDE 0701, EN 50699 / VDE 0702, IEC 62368 / EN 62368 / VDE 868-1, IEC 62911 / EN62911/ VDE 868-911	KE	•	•	•	•	•
SECUTEST DB+	KB01	0	o	•	•	•
SECUTEST DB COMFORT	KD01	0	o	o	o	•
Bluetooth [®]	M01					
Antimicrobial housing	_				•	•
* For voltage measurement or for connecting a current clamp sensor or an AT3						

For voltage measurement or for connecting a current clamp sensor or an AT3 adapter, and for temperature measurement via RTD

Key: • Included, o Optional

Detailed information regarding features and accessories can be found under "Order Information" on page 12.

Automatic Detection of Measuring Point Changes

During protective conductor measurement, the test instrument recognizes whether or not the test probe is in contact with the protective conductor, which is indicated by means of two different acoustic signals. This function is very useful where several protective conductor connections need to be tested.

Creating a Database

A test structure with data regarding customers and test objects can be created in the test instrument. This structure makes it possible to save single measurements or test sequences to devices

If the user of the test instrument is too well insulated, the following error message may appear: "Interference voltage at PE"

² Firmware version 3.2.0 and lower: 12 mA

Test Instruments for Measuring the Electrical Safety of Devices

under test belonging to various customers. Manual single measurements can be grouped together into a so-called "manual sequence".

Medical devices can be entered as test objects (Medical Device) with the SECUTEST DB COMFORT database expansion (Z853S or feature KD01), and individual test dates can be assigned to all test objects.

The SECUTEST DB+ database expansion (Z853R or feature KB01) extends the structure to include buildings, floors and rooms. Furthermore, the test structure can be set up conveniently at a PC with the help of IZYTRONIQ software (see "IZYTRONIQ Software" on page 4), and subsequently transferred to the test instrument.

Logging Functions

All of the values required for approval reports or device logbooks for electrical DUTs (e.g. per ZVEH) can be measured and stored with the test instrument. A due date for the next test is also determined

Measurement data can be documented and archived thanks to the measurement and test report that can be printed with a thermal printer which has been connected to the USB port, or stored to a USB flash drive as an HTML report (see "Data Interfaces" on page 4).

Alternatively, stored measurement data can be transferred to IZY-TRONIQ software (see "IZYTRONIQ Software" on page 4) in order to archive the data, add comments and create reports.

IZYTRONIQ Software

Suitable, database-driven test software is available, namely IZY-TRONIQ. This software facilitates test organization and the management of test data from a broad range of test instruments.

It also provides extended functions such as remote control in connection with the respective test instrument – support for extended functions depends on the test instrument and its order features or enabled extensions (activations).

The software is included with test equipment sets (see "Order Information" on page 12). If this is not the case or if you would like to take advantage of a variant with a larger scope of functions, you can purchase IZYTRONIQ separately. Detailed information can be found on our website:

https://www.gmc-instruments.de/en/ products/software-and-accessories/ software/



Display with Selectable Language

The display panel consists of a backlit, color multi-display at which menus, setting options, measurement results, instructions and error messages, as well schematics and wiring diagrams appear. Sample screenshots are shown on the next page.

The display and user prompting can be set to the desired language depending on the country in which the test instrument is used.

Data Entry

Data can be entered via a displayed softkey keyboard or a convenient touch screen for test instruments including feature E01 (e.g. SECUTEST ST PRO and SECULIFE ST BASE(25)). The menu is controlled via softkeys.

Compatible barcode readers, RFID scanners, USB keyboards and printers can also be connected via USB.

Data Interfaces

The test instrument is equipped with USB interfaces which can be used for various purposes:

- Structures set up in, and measurement data saved to the test instrument can be transferred to IZYTRONIQ database software.
 - Data can then be archived in the program, comments can be added and reports can be generated.
- Connection of compatible external input and output devices (see "Data Entry" on page 4)
- Data backup and restore with USB flash drive
- Report printing to USB flash drive or external printer
 In the case of test instruments with Bluetooth[®] (feature M01), data can thus be transmitted to IZYTRONIQ and the push-print function can be used.

Updates

The test instrument is future-proof because firmware/software updates are released on a regular basis.

Scope of Delivery

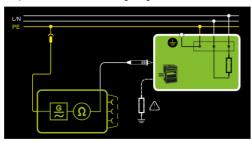
The scope of delivery varies depending on which test instrument variant has been ordered, and is country-specific. Information concerning the scope of delivery can be found under "Order Information" on page 12.

Backlit Multi-Display Samples

Single Test - Initial Screen with Parameters Display



Help - Schematic and Wiring Diagram



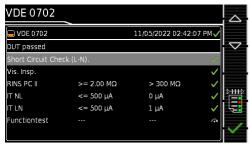
Database Structure - Customer List



Test Sequence - Start (EN 50699 / VDE 0702)



Test Sequence - Test Results (EN 50699 / VDE 0702)



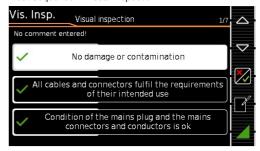
Test Sequence - Start (EN 50678 / VDE 0701)



Test Sequence - Function Test



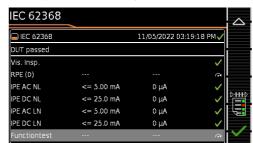
Test Sequence - Visual Inspection



Test Sequence – IPE Measurement (IEC 62368 / EN 62368 / VDE 0868-1)



Test Sequence - Test Result (IEC 62368 / EN 62368 / VDE 0868-1)



Characteristic Values

Func-	Measured	Display Range/ Nominal Range of	Reso-	Nominal Voltage	Open- Circuit	Nom. Current	Short- Circuit	Internal Resis-	S- Resis-	Measuring	Intrinsic		rload acity
tion	Quantity	Use	lution	Voltage U _N	Voltage U ₀	I _N	Current I _{SC}	tance R _I	tance R _{REF}	Uncertainty	Uncertainty	Value	Time
		1 999 mΩ	1 mΩ				>					264 V	
	Protective conductor resistance R PE	1.00 9.99 Ω 10.0 27.0 Ω	10 mΩ 100 mΩ	_	< 24 V AC or DC	_	200 mA AC / DC > 10 A AC > 35 A AC	_	_	\pm (15% rdg.+ 10 d) > 10 d > 10.0 Ω : \pm (10% rdg.+ 10 d)	±(10% rdg.+ 10 d) > 10 d	250 mA 16 A ⁵ > 42 A A C 11)	Cont.
	Insulation resistance 9	10 999 kΩ 1.00 9.99 MΩ	1 kΩ 10 kΩ	50 500	1.0 • U _N	> 1 mA	11) > 2 mA	_	_	±(5% rdg.+ 4 d) > 10 d	\pm (2.5% rdg.+2 d) > 10 d	264 V	Cont.
	Rins	10.0 99.9 MΩ 100 300 MΩ	100 kΩ 1 MΩ	V DC	1.5 • U _N					\geq 20 M Ω : \pm (10% rdg.+ 8 d)	\geq 20 M Ω : \pm (5% rdg.+4 d)		
s	Leakage current,	0 99 μA 100 999 μA	1 μA 1 μA		50		. 1 5 1	45040	1 kΩ	±(5% rdg.+ 4 d) > 10 d	$\pm (2\% \text{ rdg.} + 2 \text{ d}) > 10 \text{ d}$	0041/	04
Tests	alternative measurement ² IPE, IT, IE, IA	1.00 9.99 mA 10.0 30.0 mA	10 μA 100 μA	_	250 V~ - 20/+10%	_	< 1.5 III	> 150 kΩ	±10 Ω	> 15 mA: ±(10% rdg.+ 8 d)	> 15 mA: ±(5% rdg.+ 4 d)	264 V	Cont.
	Leakage	lp only: 0.0 99.9 μΑ	100 nA										
	current, direct	0 99 μA 100 999 μA	1 μA 1 μA	_	_	_	_	1 kΩ ±10 Ω	1 kΩ	±(5% rdg.+ 4 d) > 10 d	\pm (2.5% rdg.+2 d) > 10 d	264 V	Cont.
	measurement ³ IPE, IT, IE, IA, IP	1.00 9.99 mA 10.0 30.0 mA	10 μA 100 μA					1032					
	Leakage	0 99 μΑ	1 μΑ										
	current,	100 999 μΑ	1 μΑ										
	differential current measurement ⁴	1.00 9.99 mA 10.0 30.0 mA	10 μA 100 μA	_	_	_	_	_	_	±(5% rdg.+ 4 d) > 10 d	±(2.5% rdg.+2 d) > 10 d	264 V	Cont.
ket	IPE, IT, IG Line voltage U _{L-N} 10	100.0 240.0 V~	0.1 V	_	_		_	_		_	±(2% rdg.+2 d)	264 V	Cont.
st Soc	Load current I _L	0 16.00 A _{RMS}	10 mA	_	_	_	_	_	_	_	±(2% rdg.+2 d)	16 A	Cont.
the Tes	Active power P	0 3700 W	1 W	_	_	_	_	_	_	_	\pm (5% rdg.+10 d) > 20 d	264 V 20 A	Cont. 10 min
Test at 1	Apparent power S	0 4000 VA	1 VA			Cald	culated valu	e, U _{L-N} • I _V			\pm (5% rdg.+10 d) > 20 d	264 V	Cont.
Function Test at the Test Socket	Power factor PF with sinusoidal waveform: cosφ	0.00 1.00	0.01			Calculated	I value, P /	S, display >	10 W		±(10% rdg.+5 d)	264 V	Cont.
	Line frequency f	0 420.0 Hz	0.1 HZ					_		_	±(2% rdg.+2 d)	264 V	Cont.
t PRCD	Time to trip	0.1 999.0 ms	0.1 ms	_	_	30 mA	_	_	_	±5 ms	_	264 V	Cont.
rement	Probe voltage (probe P1 to PE) , ∼ and ≂	0.0 99.9 V 100 264 V						3 ΜΩ			±(2% rdg.+2 d)	264 V	
Voltage Measurement	Measuring voltage (V-COM sockets ⁶) , ∼ and ≅	0.0 99.9 V 100 300 V	100 mV 1 V	_	_	_	_	1 ΜΩ	_	_	±(2% rdg.+2 d) > 45 Hz 65 Hz ±(2% rdg.+5 d) > 65 Hz 10 kHz ±(5% rdg.+5 d) > 10 kHz 20 kHz	300 V —, ∼ and ≅	Cont.
I _{Leaka}	Leakage current via AT3-IIIE adapter Z745S ^{6, 8}	0.00 0.99 mA ~ 1.0 9.9 mA ~	0.01 mA 0.1 mA	_	_			_		_	±(2% rdg.+2 d) > 10 d	253 V	Cont.
y.		10 20 mA ∼	1 mA								without adapter		
Temp	Temperature, Pt100 sensor	− 200.0 +850.0 °C	0.1 °C	_	< 20 V		1.1 mA	_	_	_	±(2% rdg.+1 °C)	10 V	Cont.
	Temperature, Pt1000 sensor	− 150.0 +850.0 °C											

Func-	Nominal Rando of		Reso-	Nominal	Open- Circuit	Nom. Current	Short- Circuit	Internal Resis-	Refer- ence	Measuring	Intrinsic		rload acity	
tion	Quantity	Use	lution	Voltage U _N	Voltage U ₀	I _N	Current I _{SC}	tance R _I	Resis- tance R _{REF}	Uncertainty	Uncertainty	Value	Time	
	Current via	1 99 mA ∼	1 mA (1 mV)											
	current clamp sensor [1 mV : 1 mA]	0.1 0.99 A ∼	0.01 A (10 mV)	_	_	_	_	_	_	_				
	(V-COM sockets ^{6, 7})	1.0 9.9 A ∼	0.1 A (100 mV)									253 V		
		10 300 A ∼	1 A (1 V)											
	Comment of	0.1 9.9 mA ∼	0.1 mA (1 mV)								±(2% rdg.+2 d) > 10 d 20 Hz 20 kHz without clamp			
	Current via current clamp sensor [10 mV : 1 mA] (V-COM sockets ^{6, 7})	10 99 mA ∼	1 mA (10 mV)	_	_	_		_						
		0.10 0.99 A ∼	0.01 A (100 mV)											
I _{Clamp}		1.0 30.0 A ∼	0.1 A (1 V)										Cont.	
Clamp	Current via	0.01 0.99 mA ~	0.01 mA (1 mV)				_							
	current clamp sensor	1.0 9.9 mA ∼	0.1 mA (10 mV)					_						
	[100 mV : 1 mA] (V-COM sockets ^{6, 7})	10 99 mA ∼	1 mA (100 mV)					_ _						
	(V-COIVI SOCKELS 7)	0.10 3.00 A ∼	0.01 A (1 V)											
	Current via current clamp sensor [1000 mV : 1 mA] (V-COM sockets ^{6, 7})	1 99 µA ∼	1 μA (1 mV)											
		0.10 0.99 mA ~	0.01 mA (10 mV)	_	_			_						
		1.0 9.9 mA ∼	0.1 mA (100 mV)	_	_	_	_ _ _ _ _ _	_						
	(. 30111 0001010)	10 300 mA ∼	1 mA (1 V)											

- Known as equivalent leakage current or equivalent patient leakage current from previous standards
- Protective conductor current, touch current, device leakage current, patient leakage current
- Protective conductor current, touch current, device leakage current
- Only with feature G01 (e.g. SECUTEST ST BASE10/SECUTEST ST PRO and SECULIFE ST
- Only with feature I01 (e.g. SECUTEST ST PRO and SECULIFE ST BASE)
- Measurement types IPE_clamp and IE_clamp Measurement types IPE_AT3 adapter and IE_AT3 adapter
- The upper range limit depends on the selected test voltage.
- ¹⁰ Voltage at the test socket may be lower than measured line voltage due to components which limit inrush current
- ¹¹ Only with feature G02, e.g. SECULIFE ST BASE25

Key: rdg. = reading (measured value), d = digit(s)

Testing Times, Automatic Sequence

Testing times ("measurement duration" parameter) can be set separately for each rotary switch position during configuration of the sequence parameters. Testing times are neither tested nor calibrated.

Emergency Shutdown During Leakage Current Measurement

As of 10 mA of differential current (can also be set to 30 mA), automatic shutdown ensues within 500 ms. This shutdown does not take place during leakage current measurement with clamp meter or adapter.

Influencing Quantities and Influence Error

Influencing Quantity / Sphere of Influence	Designation per IEC 61557-16	Influence Error ± % rdg.	
Change of position	E1	_	
Change to test equipment supply voltage	E2	2.5	
Temperature fluctuation	E3	Specified influence error valid per 10 K temperature change	
0 40 °C		2.5	
Amount of current at DUT	E4	2.5	
Low frequency magnetic fields	E5	2.5	
DUT impedance	E6	2.5	
Capacitance during insulation measurement	E7	2.5	
Measured current waveform			
49 51 Hz	E8	2 with capacitive load (for equivalent leakage current)	
45 100 Hz		1 (for touch current)	
		2.5 for all other measuring ranges	

Reference Ranges

Line voltage 230 V AC ±0.2% Line frequency 50 Hz ±2 Hz

Sine (deviation between RMS and rectified Waveform

values < 0.5%)

Ambient temperature +23 °C ±2 K Relative humidity 40 ... 60% Load resistors Linear

Test Instruments for Measuring the Electrical Safety of Devices

Nominal Ranges of Use

Nominal line voltage 90 V ... 264 V AC Nominal line frequency 50 Hz ... 400 Hz Line voltage waveform Sinusoidal 0 °C ... + 40 °C Temperature

Ambient Conditions

Storage temperature -20 °C ... +60 °C

Relative humidity Max. 75%, no condensation allowed

Max. 2000 m **Flevation**

Place of use Indoors, except within specified ambient

conditions

Power Supply

Supply network TN. TT or IT Line voltage 90 V ... 264 V AC Line frequency 50 Hz ... 400 Hz

200 mA DUT: Approx. 32 VA Power consumption

10 A test: Approx. 105 VA 25 A test: Approx. 280 VA

Mains to test socket

(e.g. during function test) Continuous max. 3600 VA, power is con-

ducted through the instrument only, switching capacity ≤ 16 A, ohmic load, the AT3-IIS32 (Z745X) adapter (for example) can be used for current > 16 A AC

Electrical Safety

Protection class I per EN 61140

230 V Nominal voltage

2.3 kV AC 50 Hz or 3.3 kV DC Test voltage

(mains circuit / test socket to mains PE terminal, USB, finger contact, probe, test socket)

Designed for 300 V CAT II Measuring category

(but reduced to 250 V CAT II through the use of fuses for increased user safety. The user-friendly fuses are replaceable and replacements are easily obtainable).

Pollution degree

At DUT differential current of > 10 mA, Safety shutdown

> shutdown time: < 500 ms, can also be set to > 30 mA, with following probe current during: - Leakage current measurement:

 $> 30 \text{ mA}^{1} \sim / < 500 \text{ ms}$

- Protective conductor resistance

measurement: $> 250 \text{ mA} \sim / < 1 \text{ ms}$

in case of continuous current I > 16.5 A

Fuse links Mains fuses: 2 ea. FF 500V/16A

Probe fuse: M 250V/250mA 10 A RPE test current (feature G01 only):

1 ea. FF 500 V/16 A

Electromagnetic Compatibility

Product standard DIN EN 61326-1 DIN FN 61326-2-2

Interference emission		Class
EN 55011		В
IEC 61000-3-2		В
IEC 61000-3-3		В
Interference immunity	Test value *	Evaluation criterion
EN 61000-4-2	Contact/atmos. – 4 kV/8 kV	В
EN 61000-4-3	10 V/m (80 MHz 1 GHz)	

EN 61000-4-4	Mains connection – 2 kV	В
EN 61000-4-5	Mains connection – 1 kV (LN), 2 kV (LPE)	В
EN 61000-4-6	Mains connection – 3 V	А
EN 61000-4-8	30 A/m	А
EN 61000-4-11	0%: 1 period	В
	0%: 250/300 periods	С
	40%: 10/12 periods	С
	70%: 25/30 periods	С

USB Data Port

Type USB slave for PC connection / remote control** Type 2 ea. USB master for data entry devices* with HID

boot interface,

for USB flash drive for data backup.

for USB flash drive for saving reports as HTML files,

for printers*

See the following page for compatible devices

Remote control only with extension: "Remote Control via PC (IZYTRONIQ)" (included as standard feature with SECUTEST ST PRO and available with SECUTEST DB+ - Z853R or feature KB01).

Bluetooth® data interface 2.1 + EDR (test instruments with feature M01 only)

Frequency range Max. 2.5 mW (class II) Transmission intensity 2400 ... 2483.5 MHz

Mechanical Design

Dimensions

Display 4.3" multi-display (9.7 x 5.5 cm),

backlit, 480 x 272 pixels

at 24-bit color depth (true color) W × H × D: 295 × 145 × 150 mm

Height with handle: 170 mm

Weight SECUTEST ST BASE(10)/PRO: approx.

2.5 kg

SECULIFE ST BASE25: approx. 4.0 kg (depending on test instrument version)

Housing: IP 40 (protection against ingress Protection of solid foreign objects ≥ 1.0 mm diameter, no protection against ingress of water)

Test socket: IP 20 (protection against ingress of solid foreign objects \geq 12.5 mm diameter, no protection against ingress of water) (per EN 60529)

SECULIFE ST BASE(25):

Housing with antimicrobial properties per JIS

standard Z 2801

Database

Number of data records 50000 (1 data record = 1 DUT or

location node or customer or individual

measurement)

Regulations and standards in accordance with which the test instrument is manufactured and tested:

manaratara and tottour					
EN 61010-1	Safety requirements for electrical equipment for measurement, control and laboratory use – Part 1: General requirements				
EN 60529/	Test instruments and test procedures Degrees of protection provided by enclosures (IP code)				
EN 61326-1	Electrical equipment for measurement, control and laboratory use – EMC requirements – Part 1: General requirements				
EN 61326-2-2	Electrical equipment for measurement, control and laboratory use — EMC requirements — Part 2-2: Particular requirements — Test configurations, operational conditions and performance criteria for sensitive test and measurement equipment for EMC unprotected applications				
EN 61557-16	Electrical safety in low voltage distribution systems up to 1000 V AC and 1500 V DC – Equipment for testing, measuring or monitoring of protective measures – Part 16: Devices for testing the effectiveness of protective measures of electrical devices and/or electrical medical devices				

¹ Firmware version 3.2.0 and lower: 12 mA

Test Instruments for Measuring the Electrical Safety of Devices

Accessories

The accessories listed below are usually not included in the scope of delivery. This does not apply in the case of instrument sets which include accessories.

Order information for accessories can be found under "Order Information" on page 12.

Barcode Scanner (Z751A)

For reading 1 and 2D codes, for example barcodes and QR codes. This makes it possible to conveniently insert the ID numbers of DUTs into single measurements and test sequences.

This device is based on the concept of an instinctive scanning distance and provides best possible reading performance. Green Spot technology provides a "good-read" projection directly on the code. The device is connected via USB.



Barcode Printer (Z721E)

For printing barcode labels: Code39, Code128, EAN13, text, QR Code*, Micro QR Code, DataMatrix. Aztec.

The device is connected via USB.



Thermal Printer (Z721S)

For printing test reports on thermal paper (accessory Z722S).

The device is connected via USB.



SCANBASE RFID (Z751E) (RFID reader/writer)

Compact device for reading and writing RFID tags (13.56 MHz transponder in accordance with ISO 15693).

The device is connected via USB.



CEE Adapter for Testing Single and 3-Phase Electrical Devices (Z745A)

The Z745A CEE adapter allows for quick and efficient testing of devices equipped with a CEE plug. The adapter is equipped with the following CEE attachment outlets: 5-pole 16 A, 5-pole 32 A and 3-pole 16 A. Furthermore, the adapter includes five 4 mm safety sockets to which 3-phase devices without permanently attached plug or conventional measurement cables can be connected, e.g. by means of quick clamp terminals (not included). The following tests can be performed on devices with CEE plugs

The following tests can be performed on devices with CEE plugs with the help of the adapter:

- Testing of protective conductor continuity
- Insulation resistance, alternative leakage current (equivalent leakage current)
- Function test (3-pole CEE outlet only)

The Z745A CEE adapter may also be used as an adapter for connecting devices with 3-pole CEE plugs to common earthing contact outlets.

VL2 E (Z745W) /

Test adapter with single and 3-phase plug connectors up to CEE 32A for the performance of measurements and tests at electrical devices and extension cords with CEE plug connectors.



AT16-DI (Z750A) 3-phase 16 A Differential Current Adapter

Devices which are equipped with a 5-pole, 16 A / 6 h CEE plug can be quickly and efficiently tested with the AT16-DI CEE adapter.

The following tests can be performed on devices with CEE plugs with the help of the AT16-DI CEE adapter:



- Testing of protective conductor continuity
- Insulation resistance, alternative leakage current (equivalent leakage current)
- Measurement of protective conductor resistance with the following methods: equivalent leakage current / residual current / direct
- Function test

This differential current adapter is also available in a variant with a 5-pole 32 A / 6 h CEE plug with the designation AT32-DI CEE adapter.

Test Instruments for Measuring the Electrical Safety of Devices

AT3-III-E 3-Phase Current Adapter (Z745S)

Test adapter for active and passive testing of single and three-phase electrical devices and extension cords in conjunction with the test instrument.

Operation is simple and safe. The test adapter is connected to a 3-phase 16 A mains outlet, and to the respective test instrument. Testing is performed without reversing polarity at the device under test, either automatically or manually, and is controlled by the test sequence of the



utilized test instrument. Safety shutdown occurs if the default residual current value is exceeded.

EL1 Adapter for Testing Single-Phase Extension Cords (Z723A)



SECULOAD-N Test Adapter (Z745R)

Test adapter for testing open-circuit voltage at welding units per IEC 60974-4/EN 60974-4 / VDE 0544-4.

In combination with a test instrument, the test adapter is used for testing welding units per



IEC 60974-4 / EN 60974-4 / VDE 0544-4. This standard stipulates that peak values for open-circuit voltage may not exceed the limit values, regardless of the utilized settings.

A test sequence for testing welding units with the help of this adapter is integrated into the test instrument.

The peak-value rectifier in the SECULOAD-N uses the 1N4007 rectifier diode recommended in the standard. This is a mains rectifier diode which, due to its design, is only suitable for voltage sources with low cycle rates within the range of the line frequency, or for voltage sources with conventional transformer.

SECU-cal 10 Calibration Adapter (Z715A)

The calibration adapter is used for testing the measuring uncertainty of test instruments in accordance with DIN EN 61557-16 / VDE 0413-16 (previously DIN VDE 0404). As a rule, these instruments must be tested once each year, as



well as for certification in accordance with the ISO 9000 quality standard, as set forth by DGUV accident prevention regulation 3. All limit values for the required tests per DIN VDE such as protective conductor resistance, insulation resistance, equivalent leakage current, differential and/or touch as well as housing leakage current, must be tested.

SORTIMO L-BOXX (Z503D)

Plastic system case, outside dimensions: $W \times H \times D$ 450 × 255 × 355 mm

Z701D foam insert for test instrument and accessories must be ordered separately (see below).



Foam Insert for SORTIMO L-BOXX (Z701D)

Foam insert for test instrument and accessories.



F2030 System Soft-Case (Z700H)



Outside dimensions: $W \times H \times D$ $393 \times 275 \times$ 248 mm (without handle and carrying strap)

F2000 Universal Carrying Pouch (Z700D)



Outside dimensions: W \times H \times D 380 \times 310 \times 200 mm (without buckles, handle or carrying strap)

F2020 Universal Carrying Pouch (Z700F)



Outside dimensions: $W \times H \times D$ 430 \times 310 \times 300 mm (without buckles, handle or carrying strap)

F2010 Universal Carrying Pouch (Z700G)



Outside dimensions: W × H × D 380 × 230 × 270 mm (without carrying strap)

Further information regarding accessories can be found:

- In our Measuring Instruments and Testers catalog
- On the Internet at <u>www.gossenmetrawatt.com</u>

Sample Content



Order Information

SECUTEST ST BASE, SECUTEST ST PRO, SECULIFE ST BASE and SECULIFE ST BASE25 test instruments are available with various features and accessories, and can be ideally matched to your requirements. When ordering you can select from amongst:

- A standard model (frequently selected combinations of basic instruments and features)
- An instrument set (instrument with features and accessories which are ideally matched to a specific application
- A customized variant (instrument with features you select yourself)

Accessories can of course be purchased individually along with your instrument or at a later point in time.

Standard Models

Standard Models	Article No.	Features
SECUTEST ST BASE	M707A	Schuko variant (test socket and mains plug), selectable user interface language (default setting: German), protective conductor test current: 200 mA
SECUTEST ST PRO	M707B	Same as M707A but with 10 A protective conductor test current, with touchscreen, voltage measuring inputs, connection for 2 nd test probe and SECUTEST DB+ database expansion
SECUTEST ST PRO BT comfort	M707C	Same as M707B but with Bluetooth® port and SECUTEST DB COMFORT database expansion

Included with each instrument: Mains power cable, test probe, USB cable, plug-on alligator clip, KS17-ONE cable set for voltage measuring inputs (only with SECUTEST ST PRO and SECULIFE ST BASE(25)), travel adapter for international power supply, condensed operating instructions in printed format (complete operating instructions available for download from Internet), DAkkS calibration certificate in German, English and French, IZYTRONIQ BUSINESS Starter database and report generating software for PC (as registration card for access to download from the Internet)

Instrument Sets

Type	Designation					Article No.
Starter Package SECUTEST ST BASE	See scope of delivery below. Including IZYTRONIQ BUSINESS ADVANCED					M708A
PRO PACKAGE SECUTEST ST PRO	See scope of delivery below. Including IZYTRONIQ BUSINESS PROFESSIONAL					M708B
COMFORT PACKAGE SECUTEST PRO	See scope of delivery below. Including IZYTRONIQ BUSINESS PROFESSIONAL					M708C
WELDER's/ 3-PHASE CURRENT PACKAGE SECUTEST ST PRO	See scope of delivery below. Including IZYTRONIQ BUSINESS PROFESSIONAL					M708D
Accessories	For use with the following test packages:	STARTER PACKAGE	PRO PACKAGE	COMFORT PACKAGE	WELDER'S/ 3-PHASE CUR- RENT PACKAGE	
SECUTEST ST BASE	SECUTEST variant					
SECUTEST ST PRO	SECUTEST variant				-	
SECUTEST ST PRO BT comfort	SECUTEST variant					
SORTIMO L-BOXX	Plastic system case				2 × ■	Z503D
Foam SORTIMO L-BOXX Secutest4	Foam insert for SORTIMO L-BOXX with compartments for test instrument and accessories			-		Z701D
FOAM SORTIMO L-BOXX Adapter	Foam insert for SORTIMO L-BOXX with compartment for adapter				-	Z701E
EL1	Adapter for testing single-phase extension cords				-	Z723A
Brush probe	Probe for measuring protective conductor resistance, e.g. at rotating devices under test					Z745G
SECULOAD N	Test adapter for testing welding units in accordance with IEC 60974-4 / EN 60974-4 / VDE 0544-4					Z745R
AT16-DI	3-phase 16 A differential current adapter				-	Z750A
PC2	Probe with test tip and 2 m probe cable				-	Z745D
Adapter cable CEE16/CEE32	Adapter cable, red CEE 5-pole 16 A plug to red CEE 5-pole 32 A coupling				-	Z750F
Barcode reader	Barcode reader for 1 and 2D codes (e.g. barcodes and QR codes), with USB connection		•	-		Z751A
		Key: ■ Ind	luded 🗆 C	ptional	·	

^{*} Including DB+ database expansion

Basic Instrument Articl	e Number				M7050		
Device Variants			SECUTEST ST BASE (M7050 AA06 E00 G00 H00 I00 J00 KB00 M00)	SECUTEST ST BASE10 (M7050 AA07 E00 G01 H00 I00 J00 KB00 M00)	SECUTEST ST PRO (M7050 AA08 E01 G01 H01 I01 J00 KB01 M00)	SECULIFE ST BASE (M7050 A01 AA11 E01 G01 H01 I01 J00 KB01 KC00 M00)	SECULIFE ST BASE 25 (M7050 A01 AA12 E01 G02 H01 I01 J00 KB01 KD01 M00)
		Article No. → Feature ◆	AA06	AA07	80AA	AA11	AA12
Connections – country-	specific mains plug and test socket		1000	11101	11100		
	Germany with detection of connection and protection categories	B00					-
	UK	B01	\triangleright	\triangleright	\triangleright	\triangleright	\triangleright
	FR/CZ/PL	B03	\triangleright	\triangleright	\triangleright	\triangleright	\triangleright
	China	B04	\triangleright	\triangleright	\triangleright	\triangleright	\triangleright
	USA	B05	\triangleright	\triangleright	\triangleright	\triangleright	\triangleright
	AUS	B06	\triangleright	\triangleright	\triangleright	\triangleright	\triangleright
	DK	B07	\triangleright	\triangleright	\triangleright	\triangleright	\triangleright
	IT .	B08	\triangleright	>	D	D	>
	CH with detection of connection and protection category	B09		\triangleright	D	D	D
	Universal adapter for test socket, Germany (B00)	200	<i>V</i>				
	(for DUTs with different country-specific plugs)	B11					
	(default language which can be subsequently changed to any of				П	П	
	German	C00		(v) □ ■			
	English	C01	\triangleright	\triangleright	\triangleright	\triangleright	\triangleright
	French	C02	\triangleright	\triangleright	\triangleright	\triangleright	\triangleright
	Italian	C03	\triangleright	\triangleright	\triangleright	\triangleright	\triangleright
	Spanish	C04	\triangleright	\triangleright	\triangleright	\triangleright	\triangleright
	Czech	C05	\triangleright	\triangleright	\triangleright	\triangleright	\triangleright
	Dutch	C06	\triangleright	\triangleright	\triangleright	\triangleright	\triangleright
	Polish	C07	\triangleright	\triangleright	\triangleright	\triangleright	\triangleright
	Portuguese	C12	\triangleright	\triangleright	\triangleright	\triangleright	\triangleright
Data entry via touchscr	reen			_			
<u> </u>	None	E00					
	Included	E01			-	-	
	otective conductor measurement						
<u>.</u>	200 mA	G00					
	200 mA and 10 A ¹ (not in combination with G02)	G01		_		_	
	200 mA and 25 A	G02					
Connection for 2 nd test		G02					_
	None	H00					
							_
	Included	H01					-
	oltmeter) with 2 additional measurement inputs, COM–V	100		_			
	None	100		-	_	_	
	Included	101					
Jacks for applied parts							
	None	J00		_	_	_	
Additional test sequence							
	None	KA00					
SECUTEST DB+ databa	se expansion (corresponds to Z853R)						
	None	KB00					
	Included	KB01					
SECUTEST DB COMFORT	database expansion (corresponds to Z853S)						
	None	KD00					
	Included	KD01					
Bluetooth [®]		-					
	None	M00					
	Included	M01		_	_		-
	ficate (language combinations)	IVIOT					
		P00	-				_
	In D/GB/F						
	In D/GB/PL	P01	\triangleright	\triangleright	\triangleright	\triangleright	\triangleright
	In D/GB/IT	P02	\triangleright	\triangleright	\triangleright	\triangleright	

^{1 10/25} A R_{PF} measurements are only possible with line voltages of 115/230 V and line frequencies of 50/60 Hz.

Sample Order

Sample order for a SECUTEST ST BASE10 with English user interface: ____

M7050 AA02 C01 G01

AA02: SECUTEST BASE10 device variant

C01: English user interface, keyboard layout and test sequences G01: R-PE test current for protective conductor measurement:

200 mA and 10 A

Test Instruments for Measuring the Electrical Safety of Devices

Designation	Туре	Article No.
Mains cable		
Cable set for connecting test instruments to		
the mains without using a an earthing contact		
outlet, and for connecting DUTs. Consists of		
coupling socket with 3 permanently connected		
cables, 3 measurement cables, 3 plug-on pick-up clips and 2 plug-on test probes.	KS13	GTY3624065P01
pick-up clips and 2 plug-on test probes.	NOIO	G113024003F01
Adapter for Testing 3-Phase Current Cons	umers	
Adapter for connecting DUTs:		
3-pole 16 A, 5-pole 16 A + 32 A, 5 ea. 4 mm socket		
For all tests without mains voltage		
For single and 3-phase electrical devices		
 For leakage current measurement, 		
direct or differential current method	CEE adapter	Z745A
16 A/32 A 3-phase current adapter		
(test case) - For all tests without mains voltage		
For single and 3-phase electrical devices		
For tests at single and 3-phase extension		
cords		
For leakage current measurement,		
direct method For leakage current measurement,		
differential current method ¹	AT3-III-E D	Z745S
Test adapter for testing devices with CEE16	7.10 111 2	27 100
and CEE32 connectors (max. load capacity:		
20 A)	AT3-IIS ^{D, 1}	Z745T
Test adapter for testing devices with CEE16		
and CEE32 connectors (max. load capacity: 32 A)	AT3-II S32 ^{D, 1}	Z745X
3-phase 16 A differential current adapter	AT16-DI	Z750A
3-phase 32 A differential current adapter	AT32-DI	Z750B
Test adapter with single and 3-phase plug		
connectors up to CEE 32A		
For all tests without mains voltage		
For single and 3-phase electrical devices For tests at single and 3-phase extension		
cords	VL2E	Z745W
Adapter cable, red CEE 5-pole 16 A plug to		
red CEE 5-pole 32 A coupling, 0.5 m,	CEE16/CEE32	
$5 \times 1.5 \text{ mm}^2$	adapter cable	Z750F
Adapter for Testing Single-Phase Extension	on Cords	
Leakage current clamp meter		
(current clamp) for SECUTEST ST PRO		
0.1 mA 25 mA AC Frequency range: 50 Hz 1 MHz,		
transformation ratio: 100 mV / mA,		
clamp opening: 40 mm max. cable dia.	SECUTEST CLIP	Z745H
Adapter for testing single-phase extension		
cords including earth contact and inlet plug		
inserts	EL1	Z723A
Plug insert for using the EL1 adapter in Switzerland	DDO OU	CT7000F000D00
SWIZERIARIU	PRO-CH	GTZ3225000R000
Adapter for Testing Welding Units		
Test adapter in combination with SECUTEST		
ST for testing welding units in accordance with IEC 60974-4 / EN 60974-4 /		
VDE 0544-4.		
The peak-value rectifier in the SECULOAD-N		
uses the 1N4007 rectifier diode recom-		
mended in the standard.		
This is a mains rectifier diode which, due to		
its design, is only suitable for voltage sources with low cycle rates within the range		
of the line frequency, or for voltage sources		
with conventional transformer.		
Includes 4 measurement cables and 2 alliga-		
tor clips.	SECULOAD-N	Z745R

SECULOAD-N

tor clips.

Z745R

Designation	Туре	Article No.
Calibration Adapter		
Calibration adapter for test instruments per		
DIN EN 61557-16 / VDE 0413-16 (previ-		
ously DIN VDE 0404) (max. 200 mA) not for use with 10 A protective conductor test		
current	SECU-cal 10	Z715A
Current	OLOO CAI TO	ZITOA
Probe Cables	1	
Probe cable with test probe and 2 m probe	B00	77.450
cable (not coiled), 300 V CAT II 16 A	PC2	Z745D
Probe cable with test probe and 2 m probe	SK2W	77.4EN
cable (coiled), 300 V CAT II 16 A 5 m probe cable for protective conductor	SNZW	Z745N
measurement, 300 V CAT II 16 A	PC5	Z7450
Brush probe	Z745G	Z745G
Distributor for connecting five 4 mm and five	21 400	21400
2 mm test probes for measuring multiple,		
accessible housing parts or applied parts	SV5	Z745J
Cable set (1 pair of measurement cables)		
1.2 m, with VDE-GS mark,		
600 V CAT IV 1 A *, 1000 V CAT III 1 A *		
1000 V CAT II 16 A **		
* With plugged on safety caps ** Without plugged on safety caps	KS17-2	GTY3620034P0002
2 pieces in a plastic bag, diameter: 4 mm,	Measuring cable	011302000 1 1 0002
length: 1.0 m, 1000 V CAT III, 19 A, blue	set, blue	Z746A
2 pieces in a plastic bag, diameter: 4 mm, length:	Measuring cable	
1.0 m, 1000 V CAT III, 19 A, black/red	set, black/red	Z746B
Ourseast Clause Consess for CECUTECT CT		DACE(OE)
Current Clamp Sensors for SECUTEST ST	PRU/SECULIFE ST I	BASE(25)
Switchable current clamp sensor, 1 mA 15 A and 1 A 150 A,		
frequency range: <u>45 65</u> 500 Hz,		
transformation ratio: 1 mV/mA and 1 mV/A,		
clamp opening: 15 mm max. cable dia.	WZ12C D	Z219C
Leakage current clamp meter, 0.1 mA	_	
25 mA, 100 mV/mA	SECUTEST CLIP D	Z745H
Temperature Sensors for SECUTEST ST PR	RO/SECULIEE ST RA	\SF(25)
Pt100 temperature sensor, -40 +500 °C	IO/OLOOLII L OI DA	101(20)
for surface and immersion measurements	Z3409	GTZ3409000R0001
Pt1000 temperature sensor, class B, for		
measurement in gases and liquids,		
-50 +220 °C	TF220	Z102A
Pt100 oven sensor, -50 +550 °C	TF550	GTZ3408000R0001
Dip-stick oil temperature sensor, Pt1000		
class B, -50 +500 °C,		
sensor: 3 mm dia. × 810 mm long	TF400CAR	Z102C
Pouches and Cases		
Carrying pouch for the test instrument	F2000 ^D	Z700D
Large carrying pouch for test instrument sets	F2020	Z700F
Universal carrying pouch with flexible com-		
partments and display guard for the test in-		
strument	F2010	Z700G
System soft-case	F2030	Z700H
Plastic system case	SORTIMO L-BOXX	Z503D
Foam insert for SORTIMO L-BOXX with com-	Foam SORTIMO	
	1 5010/0 1 14	7704D
partments for test instrument and accessories	L-BOXX Secutest4	Z701D
partments for test instrument and accessories Foam insert for SORTIMO L-BOXX GM with compartment for adapter	Foam SORTIMO L-BOXX adapter	Z701D Z701E

	Article No.
SECUTEST DB+	Z853R *
SECUTEST DB	
COMFORT	Z853S *
SCANBASE RFID	Z751E
_ 5,DOE III ID	
7751R	Z751R
270111	270111
7751S	Z751S
27010	27010
7751T	Z751T
27011	27011
7751Δ	Z751A
ZIOIN	LIOIN
T	
7721F	7721E
7722D	7722D
2,225	2,223
Z722E	7722E
Z721S	Z721S
Z722S ^D	Z722S
DEID occurred be	do rooder and neister
KEILL GCANNER NAICC	ide reader and brinter
	SECUTEST DB COMFORT SCANBASE RFID Z751R Z751S Z751T Z751A Z721E Z722D Z722E

Gossen Metrawatt GmbH

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The test instrument's serial number must be included with the order.

Data sheet available
Only with feature I01(e.g. SECUTEST ST PRO and SECULIFE ST BASE)